EXAMINER	F REFEREN	PATENT AND CES CITED BY APF all sheets if necessary)		ATTY. DOCKET N 100564-0010 APPLICANT RAUTH et al. FILING DATE	6	10	New New	169	97
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A A	AG 0389063 A	09/26/1990	EPO						
(CS) A	AH 0580305 A	01/26/1994	EPO						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)									
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Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

\*EXAMINER: